

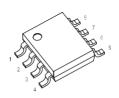


# Product data sheet

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SOP-8

D1 D1 D2 D2 80 70 60 50 10 20 30 40 S1 G1 S2 G2

P-Channel MOSFET

Parameter		Symbol	Мах	timum	Units	
Drain-Source Voltage		V <sub>DS</sub>	-30		V	
Gate-Source Voltage		V <sub>GS</sub>	±20		V	
Continuous Drain	T <sub>A</sub> =25°C T <sub>A</sub> =70°C		1-	-5		
Current			-I <sub>D</sub>	-	4.2	A
Pulsed Drain Current <sup>c</sup>		I <sub>DM</sub>	-	-30		
Avalanche Current <sup>c</sup>		I <sub>AS</sub> , I <sub>AR</sub>	17		A	
Avalanche energy L=0.1mH <sup>c</sup>		E <sub>AS</sub> , E <sub>AR</sub>	14		mJ	
	T <sub>A</sub> =25°C		P <sub>D</sub>	2		w
Power Dissipation <sup>B</sup>	T <sub>A</sub> =70°C			1.3		7 ~ ~ ~
Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>STG</sub>	-55 to 150		°C	
Thermal Characteris	tics					
Parameter		Symbol	Тур	Max	Units	
Maximum Junction-to-Ambient <sup>A</sup> t ≤ 10s		R <sub>0JA</sub> —	48	62.5	°C/W	
Maximum Junction-to-Ambient <sup>A D</sup> Steady-State			74	110	°C/W	
Maximum Junction-to-Lead Steady-State		R <sub>eJL</sub>	35	40	°C/W	

## Product Summary

V <sub>DS</sub>	-30V
I <sub>D</sub> (at V <sub>GS</sub> =-10V)	-5A
R <sub>DS(ON)</sub> (at V <sub>GS</sub> =-10V)	< 52m $\Omega$
$R_{DS(ON)}$ (at $V_{GS}$ = -4.5V)	< 87m $\Omega$



#### Electrical Characteristics (TJ=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC P	PARAMETERS		-				
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	I <sub>D</sub> =-250μA, V <sub>GS</sub> =0V		-30			V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =-30V, V <sub>GS</sub> =0V				-1	μA
		Γ	TJ=55°C			-5	μΑ
I <sub>GSS</sub>	Gate-Body leakage current	$V_{DS}$ =0V, $V_{GS}$ = ±20V				±100	nA
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS}=V_{GS} I_D=-250 \mu A$		-1.4	-1.9	-2.4	V
I <sub>D(ON)</sub>	On state drain current	V <sub>GS</sub> =-10V, V <sub>DS</sub> =-5V		-30			Α
		V <sub>GS</sub> =-10V, I <sub>D</sub> =-5A			32	52	mΩ
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance		TJ=125°C		48	70	1115.2
		$V_{GS}$ =-4.5V, I <sub>D</sub> =-4A			51	87	mΩ
<b>g</b> <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> =-5V, I <sub>D</sub> =-5A			13		S
$V_{SD}$	Diode Forward Voltage	I <sub>S</sub> =-1A,V <sub>GS</sub> =0V			-0.7	-1	V
ls	Maximum Body-Diode Continuous Current					-2.5	Α
	PARAMETERS						
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =-15V, f=1MHz			520		pF
C <sub>oss</sub>	Output Capacitance				100		pF
C <sub>rss</sub>	Reverse Transfer Capacitance				65		pF
Rg	Gate resistance	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz		3.5	7.5	11.5	Ω
SWITCHI	NG PARAMETERS						
Q <sub>g</sub> (10V)	Total Gate Charge	-V <sub>GS</sub> =-10V, V <sub>DS</sub> =-15V, I <sub>D</sub> =-5A			9.2	11	nC
Qg(4.5V)	Total Gate Charge				4.6	6	nC
$Q_{gs}$	Gate Source Charge				1.6		nC
$Q_{gd}$	Gate Drain Charge				2.2		nC
t <sub>D(on)</sub>	Turn-On DelayTime	$V_{GS}$ =-10V, $V_{DS}$ =-15V, $R_L$ =3 $\Omega$ , $R_{GEN}$ =3 $\Omega$			7.5		ns
tr	Turn-On Rise Time				5.5		ns
t <sub>D(off)</sub>	Turn-Off DelayTime				19		ns
t <sub>f</sub>	Turn-Off Fall Time				7		ns
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =-5A, dI/dt=100A/μs			11		ns
Q <sub>rr</sub>	Body Diode Reverse Recovery Charge	I <sub>F</sub> =-5A, dl/dt=100A/μs			5.3		nC

A. The value of  $R_{\theta,JA}$  is measured with the device mounted on  $1in^2$  FR-4 board with 2oz. Copper, in a still air environment with  $T_A = 25^{\circ}$  C. The value in any given application depends on the user's specific board design.

B. The power dissipation P\_D is based on  $T_{J(MAX)}$ =150  $^{\circ}~$  C, using  $\leqslant~$  10s junction-to-ambient thermal resistance.

C. Repetitive rating, pulse width limited by junction temperature  $T_{J(MAX)}$ =150° C. Ratings are based on low frequency and duty cycles to keep initial  $T_J$ =25° C.

D. The  $R_{\theta JA}$  is the sum of the thermal impedence from junction to lead  $R_{\theta JL}$  and lead to ambient.

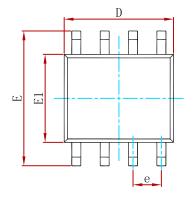
E. The static characteristics in Figures 1 to 6 are obtained using  ${<}300\mu s$  pulses, duty cycle 0.5% max.

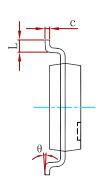
F. These curves are based on the junction-to-ambient thermal impedence which is measured with the device mounted on  $1in^2$  FR-4 board with 2oz. Copper, assuming a maximum junction temperature of  $T_{J(MAX)}$ =150° C. The SOA curve provides a single pulse rating.

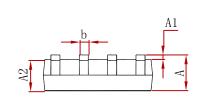


AO4803-MS HF Roms Semiconductor Compiance

#### PACKAGE MECHANICAL DATA

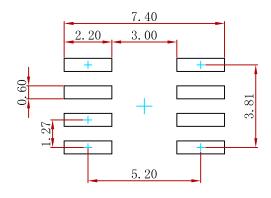






Symbol	Dimensions In	Millimeters	Dimensions In Inches		
Symbol	Min	Max	Min	Max	
А	1.350	1.750	0.053	0.069	
A1	0.100	0.250	0.004	0.010	
A2	1.350	1.550	0.053	0.061	
b	0.330	0.510	0.013	0.020	
с	0.170	0.250	0.007	0.010	
D	4.800	5.000	0.189	0.197	
e	1.270 (BSC)		0.050 (BSC)		
Е	5.800	6.200	0.228	0.244	
E1	3.800	4.000	0.150	0.157	
L	0.400	1.270	0.016	0.050	
θ	0 °	8°	0 °	8°	

#### Suggested Pad Layout



#### Note:

1.Controlling dimension:in millimeters.

2.General tolerance:± 0.05mm.
3.The pad layout is for reference purposes only.

#### **REEL SPECIFICATION**

P/N	PKG	ΟΤΥ
AO4803-MS	SOP-8	4000
A04003-M0	501-0	1000





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